Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/516,441	IRTH ET AL.	
Examiner	Art Unit	
Bin Shen	1655	

Subclass	Date 8/30/2006	Examiner
NA	8/30/3006	
	0/30/2000	BS
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
STN/WEST-see printout.	8/30/2006	BS		
Priority document checked.	8/30/2006	BS		
Inventor name searched.	8/30/2006	BS		
SEQ search: NA.	8/30/2006	BS		